

<b>FORM PTO-1449</b> (Rev. 2-32)	<b>U.S. Department of Commerce</b> <b>Patent and Trademark Office</b>	<b>Atty. Docket No.</b> 005092.00028	<b>Serial No.</b> 10/003,837
<div style="display: flex; align-items: center;"> <div> <b>SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>             (Use several sheets if necessary)         </div> </div>		<b>Applicant:</b> Tim Peck et al	
		<div style="display: flex;"> <div style="flex: 1;"> <b>Filing Date:</b>            December 3, 2001         </div> <div style="flex: 1;"> <b>Group:</b>  <del>1632</del> 2859         </div> </div>	

### U.S. PATENT DOCUMENTS

Examiner Initial		Document Number	MM/DD/YY Date	Name	Class	Subclass	Filing Date if Appropriate
TAF		6 1 0 3 1 9 9	8/15/00	Randy McCormick et al Bjornson et al	422	100	

### FOREIGN PATENT DOCUMENTS

	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
TAF	0 0 5 0 9 2 4	8/31/00	WO				
TAF	1 9 9 2 7 9 7 6	1/13/00	DE				X

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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc).

TAF	Dechow J et al: "Fabrication of NMR Microsensors for Nanoliter Sample Volumes" vol. 53, no. 1-4, June 2000 International Search Report based off of PCT/US/46733
<b>EXAMINER</b> <i>Tiffany A. Feyrer</i>	<b>DATE CONSIDERED</b> <i>March 21st 2003</i>

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